Application/Control No. O9/462,796 Examiner Thanh T. Nguyen Applicant(s)/Patent Under Reexamination WATANABE ET AL. Art Unit Page 1 of 1

Notic of References Cited

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-			
	В	US-			
	С	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Н	US-			, 12 · · · · · · · · · · · · · · · · · ·
	1	US-			
	J	US-			
	к	US-			
i	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	05-121409	05-1993	Japan	Akira	H01I 21/92
	0					· · · · · · · · · · · · · · · · · · ·
	Р				-	·
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

	TOTAL				
*	<u> </u>	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	٧				
	w				
	×				

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.